Active screen plasma surface co-alloying of 316 austenitic stainless steel with both nitrogen and niobium for the application of bipolar plates in proton exchange membrane fuel cells

Kaijie Lin*, Xiaoying Li, Linhai Tian, Hanshan Dong

School of Metallurgy and Materials, The University of Birmingham, Birmingham B15 2TT, UK

A R T I C L E  I N F O

Article history:
Received 10 April 2015
Received in revised form 27 May 2015
Accepted 3 June 2015
Available online 2 July 2015

Keywords:
Proton exchange membrane fuel cells
Bipolar plates
316 stainless steel
Active screen plasma surface alloying
Nitrogen
Niobium

A B S T R A C T

Austenitic stainless steel has been researched as a promising candidate material for bipolar plates in proton exchange membrane fuel cells. However, its interfacial contact resistance (ICR) is about 16 times higher than that of the Department of Energy (DOE) target (10 mΩ cm²), which leads to undesirable fuel cell performance. In this work, a new hybrid plasma surface engineering process, based on active screen plasma co-alloying, has been developed to simultaneously alloy 316 austenitic stainless steel (316 SS) surfaces with both nitrogen and niobium. The results demonstrated that the layer structure of the modified surfaces can be tailored by adjusting the treatment conditions. All the plasma treated 316 SS samples exhibited significantly reduced ICR below the DOE target of 10 mΩ cm². The corrosion resistance of the N/Nb co-alloyed 316 SS was much better than active screen plasma nitrided and marginally better than the untreated material.

Copyright © 2015, The Authors. Published by Elsevier Ltd on behalf of Hydrogen Energy Publications, LLC. This is an open access article under the CC BY license (http://creativecommons.org/licenses/by/4.0/).

Introduction

As an efficient, clean and quite power source, proton exchange membrane fuel cells (PEMFCs) have received extensive interest in the last decade mainly due to the concerns over severe air pollution caused by conventional power sources and the depletion of fossil energies. Significant improvement has been made recently in the efficiency and performance of PEMFCs. However, the wide commercial application of PEMFCs has been retarded, to a large extent, by the low mechanical strength and the high fabrication cost of graphite bipolar plates [1].

To this end, great efforts have been made to explore metallic bipolar plates, such as aluminium alloys [2,3], titanium alloys [4,5] and amorphous alloys [6,7]. Among them, austenitic stainless steels (SS) have attracted more and more attention as promising candidates for bipolar plate application mainly because of their good mechanical performance, relatively low cost and ease of manufacture.
Materials and methods

Materials and sample preparation: Commercial 316 austenitic stainless steel (316 SS) was selected as the substrate, and its chemical composition is (wt%): 0.06% C, 17.20% Cr, 1.30% Mn, 2.20% Mo, 11.70% Ni, 0.014% S and Fe balanced. Coupon samples of 6 mm in thickness were cut off from 1 inch (25.4 mm) hot rolled bars using a SiC cutting wheel. The front side of the coupon samples was firstly wet ground with silicon carbide abrasive paper up to #1200 grit and subsequently polished using 6 µm and 1 µm diamond pastes. The backside was wet ground up to #1200 grit. Prior to treatment, samples were washed with soapy water, cleaned with acetone in ultrasonic bath for 5 min, and finally dried under hot flowing air.

Cross sections were cut from treated coupon samples and mounted in conductive bakelite. The mounted samples were wet ground and then polished using the same procedures as described above. In order to reveal the micro-structure of the cross sections, an etching agent containing 25 ml H2O, 25 ml HNO3 and 50 ml HCl was used. After etching for about 20 s, samples were rinsed immediately with water then acetone, and dried in hot flowing air.

Active screen plasma treatments: Active screen plasma surface co-alloying treatments with both N and Nb (ASPA(N + Nb)) were conducted in an AS Plasma Metal 75 kVA industrial scale furnace and the experimental setting for the ASPA(N + Nb) treatment is shown in Fig. 1, schematically. The small metal active screen was placed on the worktable of the large furnace, where bias was applied. The lid of the active screen was specially designed to carry niobium. The sample was insulated by ceramic and hence stayed at a floating potential. The effect of bias on the small metal active screen was studied using three different biases: 5%, 10% and 15% of the main power supply of 15 kVA, and the treatment parameters as well as the sample codes are listed in Table 1.

Characterization methods: The phase constituent of the plasma treated samples was investigated using XRD (Bruker D8 Advance) with Cu Kα radiation (λ = 0.154 nm). The surface morphology and the cross-sectional microstructure of the samples before and after treatment were observed using SEM (Jeol 7000). The chemical compositions of the treated surfaces and cross-sections were examined by EDS (Oxford Instrument Inca). The composition and chemical state of the elements were analysed by XPS (Theta Probe). Elemental concentration depth profiles were determined by glow discharge optical emission spectroscopy (GDOES) (Leco GDS-750). The hardness depth profiles were probed using nano-indentation (Nano Test 600).

Corrosion tests: The corrosion behaviour of untreated and plasma treated 316 SS samples under different conditions was evaluated by electrochemical tests consisting of potentiodynamic polarization and potentiostatic polarization. A standard three electrodes system was employed in the polarization tests. A platinum rod, a saturated calomel electrode (SCE) and the to-be-measured sample were acted as the counter electrode, the reference electrode and the working electrode, respectively. The Gamry electrochemical workstation was used to measure and record the corrosion data. To simulate the working environment of PEMFC, a sulphuric acid
aqueous solution (0.5 M H₂SO₄ + 2 ppm HF) was selected as the corrosion solution. Prior to the potentiodynamic polarization, an open circle potential (OCP) test was conducted for 1 h to stabilize the sample in the corrosion solution. The potentiodynamic polarization scan started from 0.6 V (vs SCE) to 1.2 V (vs SCE) at a sweep rate of 1 mV/s. For the potentiostatic polarization, constant potentials of 0.6 V (vs SCE) and 0.1 V (vs SCE) were applied to the sample for 4 h, to simulate the cathode and anode environment, respectively.

Interfacial contact resistance: The interfacial contact resistance was measured using Wang’s method [28]. In brief, the to-be-measured sample was sandwiched between two pieces of carbon paper (Tory 120), and further sandwiched between two copper plates under a compaction force of 140 N/cm². A constant current was applied onto this assembly cell through the copper plates. By measuring the voltage drop of this cell, the total resistance can be calculated. A micro-ohm meter (TTi BS407) was used to apply the current and present the resistance directly. To eliminate the influence of the back side of the sample, gold-coating was applied on it, so the resistance could be neglected.

Results

Surface morphology of ASPA(N + Nb) samples

The surface morphology and composition of the active-screen plasma N/Nb co-alloyed i.e. ASPA(N + Nb) treated samples as a function of the applied bias (Bs) are shown in Fig. 2. It can be seen that the surface morphology was similar for the 5%Bs sample (Fig. 2(a)) and 10%Bs sample (Fig. 2(b)), which consisted of particles with a similar size of about 100 nm. However, when increased the applied bias to 15% (Fig. 2(c)), the size of surface particles became uneven with very small particles and relatively larger clusters but the density of the surface layer was improved with reduced number of pinholes. The EDS surface composition of the three ASPA(N + Nb) treated samples is compared in Fig. 2(d). It can be seen that the content of the alloyed Nb increased markedly with the increase of the bias used; in contrast, the content of Cr, Ni and Fe decreased with the increase of the bias used. The light element N was measured using XPS and the results are reported in Section 3.2.2.

Phase constitute of the ASPA(N + Nb) treated surfaces

XRD

The XRD patterns of ASPA(N + Nb) treated samples under different applied biases are plotted in Fig. 3. It can be seen from the XRD profile of the 5%Bs sample that an additional set of peaks can be observed apart from the peaks of the austenitic stainless steel substrate. Comparing with the peaks of the substrate, those additional peaks moved to a lower angle and were broaden to some extent. These are characteristic features of the S-phase formed in low-temperature plasma nitrided austenitic stainless steel [29]. However, comparing with the XRD data in the literature [19], the angle shifting of the 5% Bs sample is relatively smaller, which will be discussed in Section 4.2. No peaks of niobium nitride could be found from the XRD pattern of the 5% Bs sample. For the samples treated by 10% and 15% bias, apart from the peaks of the substrate, the peaks of Nb₄N₅ can also be detected. The dominated orientation of Nb₄N₅ changed from (211) for the 10% Bs sample to (310) for the 15% Bs sample. No peaks of S-phase can be found from the XRD patterns of the 10% Bs and 15% Bs samples.

XPS

The chemical states of Nb, N and Fe in ASPA(N + Nb) treated surfaces were analysed by XPS and the spectrums were

---

**Table 1** - Plasma treatment parameters and sample codes.

<table>
<thead>
<tr>
<th>Sample</th>
<th>Temperature (°C)</th>
<th>Duration (h)</th>
<th>Gas</th>
<th>Pressure (mbar)</th>
<th>Applied bias (% of 15 kVA)</th>
</tr>
</thead>
<tbody>
<tr>
<td>5% Bs</td>
<td>450</td>
<td>10</td>
<td>25%N₂ + 75%H₂</td>
<td>0.75</td>
<td>5</td>
</tr>
<tr>
<td>10% Bs</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>10</td>
</tr>
<tr>
<td>15% Bs</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>15</td>
</tr>
</tbody>
</table>
obtained after argon ions sputtering for 60s, 180s, 360s and 540s. The XPS spectrums of N 1s and Nb 3d for 5%Bs sample are shown in Fig. 4(a) and (b). It can be seen from these XPS spectrums that the binding energy of N 1s and Nb 3d did not change significantly with the sputtering time (or depth). The binding energy of N 1s was determined to be 397 eV, which was lower than that of the standard binding energy of N 1s (398.4 eV). The binding energy of Nb 3d was identified as 203.4 eV and 206.3 eV, which were higher than the corresponding standard binding energy of metallic niobium (202.3 eV and 205 eV). The obtained values of the binding energy of Nb 3d and N 1s were in good agreement with the results reported by other researchers [30] and the deviation from the standard binding energy implied the formation of niobium nitride. Other conclusions can also be drawn from Fig. 4(a) and (b) are that the intensity of the Nb 3d and N 1s spectrums decreased with the increase of the sputtering time, and the peak of Nb 3d totally vanished but N 1s still remained after sputtering for 540s. Taking the relatively low sputtering rate of XPS into account, the niobium nitride layer formed on the 5% Bs sample must be very thin. Such a thin niobium nitride layer was difficult to be detected by XRD, resulting in the absence of niobium nitride peaks in the XRD pattern of the 5%Bs sample (Fig. 3).

The N and Nb spectrums of 10%Bs and 15%Bs samples are shown in Fig. 4(c) and (d) and (e) and (f), respectively. It can be
Fig. 4 – The N1s and Nb3d XPS spectrums of ASPA(N + Nb) samples: (a)&(b) 5%Bs, (c)&(d) 10%Bs, (e)&(f) 15%Bs and (g) the quantitative XPS results at 360s sputtered surfaces.
seen that the N and Nb spectrums obtained from the 10%Bs sample were the same as those from the 15%Bs sample. Except for the spectrums of 60s-sputtered surface, other spectrums of 180s, 360s and 540s sputtered surfaces exhibited almost identical profiles. The binding energy of N 1s and Nb 3d identified from the surfaces of the 10%Bs and the 15%Bs samples was the same as that determined from the 5%Bs sample. Therefore, the XPS results of the 10%Bs and the 15%Bs samples also indicated the formation of a niobium nitride layer on the surface of these two samples and the niobium nitride layers were thicker than that formed on the surface of the 5%Bs sample as these spectrums were independent of the sputtering time up to 540s.

The spectrums obtained after argon irons sputtering for 360s were quantitatively analysed and the results are summarized in Fig. 4(g). It can be clearly seen that the atomic percentage of N and Nb increased with the increase of the applied bias. The identification of NbN5 peaks from the XRD patterns (Fig. 3) was in agreement with the quantification analysis of the XPS spectrums. The atomic ratio of N/Nb for the 15%Bs sample was around 1.23, which was close to that of the NbN5 (1.25).

Apart from niobium and nitrogen, iron was also detected by XPS. The binding energy of iron was determined to be 706.7 eV and the peak position did not change after different sputtering durations (Fig. 5). It follows that iron existed in pure metal state in the modified surfaces, and the intensity of the Fe 2p peaks reduced gradually with the increase of applied bias. The content of Fe quantified from the XPS spectrums of 360s sputtered surfaces decreased with the increase of the applied bias from 30.5 at% for the 5% Bs samples to 17.0 at% for the 10% Bs samples and 8.2 at% for the 15% Bs samples. A very low amount of chromium and nickel was found by XPS as well.

Layer structure of the ASPA(N + Nb) treated samples

The low and high magnification cross-sectional images of ASPA(N + Nb) treated samples are shown in Fig. 6. The samples observed under low magnification were etched, while the samples observed under high magnification were not etched to optimally reveal the microstructural features.

For the sample treated with 5% bias (i.e. 5% Bs), a featureless layer was found on the top of the surface in the low magnification SEM image (Fig. 6(a)). The GDOES nitrogen depth profile as inlet in Fig. 6(a) indicated the high nitrogen content in this featureless layer. The maximum nitrogen content was found to be around 15 at% in this featureless layer, which was much higher than that of the maximum solid solubility of N in austenitic stainless steel (8.7 at%), reported in literatures [31,32]. Referring to the typical features observed in the previous research [19] and taking the XRD results (Fig. 3) into account, this layer can be identified as the nitrogen supersaturated expanded austenite, i.e. the so-call S-phase [29].

Under high magnification, a dark thin layer was observed on the top of the S-phase case formed on 5% Bs sample (Fig. 6(b)). The EDS element line-scan indicated that this thin dark layer was rich in niobium.

For 10%Bs and 15%Bs samples, a white dense layer can be found on the top of the severely eroded substrate and no S-phase case can be found from those two samples (Fig. 6(c) and (e)). In addition, a groove can be observed between the white layer and the substrate. From the high magnification back-scattered electron (BSE) images of the 10% Bs and 15% Bs samples (Fig. 6(d) and (f)), it can be seen that the top layer was dense and columnar structured, which was in agreement with the surface morphology observed under SEM (Fig. 2). The EDS line-scan also proved that the surface layer contained a high level of niobium. Taking the results of SEM, XPS and XRD into account, this layer can be deduced as the NbN5 layer. The formation of the groove observed after etching (Fig. 6(c) and (e)) was most probably due to the huge difference in corrosion resistance between the top Nb nitride layer and the substrate. The thickness of the niobium nitride layer and the S-phase case is compared in Fig. 6(g) as a function of the bias used. It can be seen that the thickness of the niobium nitride layer increased with the increase of the applied bias.

Corrosion behaviour

The potentiodynamic polarization curves of ASPA(N + Nb) treated samples are drawn in Fig. 7(a). It can be seen clearly that the ASPA(N + Nb) treated samples exhibited more positive corrosion potential than that of the untreated and typical ASPN treated samples. The passive current density of the ASPA(N + Nb) treated samples was higher than that of the untreated sample but lower than that of the typical ASPN treated sample. It is also noted that in general the passive current density reduced with the increase of the applied bias.

![Fig. 5](image-url) - The Fe 2p XPS spectrums of ASPA(N + Nb) samples (a) 5% Bs (b) 10% Bs (c) 15% Bs.
Fig. 6 – Cross-sectional images of ASPA(N + Nb) samples: Low magnification image of (a) 5%Bs, (c) 10%Bs, (e) 15%Bs. High magnification image of (b) 5%Bs, (d) 10%Bs, (f) 15%Bs, (g) the thickness of S-phase and deposition layer of ASPA(N + Nb) samples.
In particular, the 15%Bs sample showed the lowest passive current density among plasma treated samples, almost one order of magnitude lower than that of the ASPN treated sample.

The corrosion potential (E_{corr}) and corrosion current density (I_{corr}) of all the samples were quantitatively calculated from the potentiodynamic polarization curves and the results are summarized in Table 2. It can be seen that the E_{corr} of the ASPA(N + Nb) treated sample increased with the applied bias and was much higher than that of the untreated and the ASPN treated sample. For the corrosion current density, the 10%Bs sample showed a higher I_{corr} than that of both the 5% Bs and the 15%Bs samples. Two possible reasons might have caused the relatively high corrosion current density of the 10%Bs sample. Firstly, compared with the 15%Bs sample, the niobium nitride layer formed on the 10%Bs sample was too porous (Fig. 2(b)) and too thin (Fig. 6(d)) to protect against the aggressive corrosion solution. Secondly, compared with the 5%Bs sample, no corrosion resistant S-phase case formed in the 10%Bs sample. Hence, severe corrosion would occur when the corrosion solution was penetrated through the pinholes in the niobium nitride layer and reached the substrate. It is obvious from Table 2 that the 15%Bs sample exhibited the best corrosion resistance in terms of the highest corrosion potential and the lowest corrosion current density.

Due to the best potentiodynamic performance, the 15%Bs sample was selected for further potentiostatic polarization tests. The potentiostatic polarization results of the untreated sample and the 15%Bs sample under (b) −0.1 V and (c) 0.6 V are plotted in Fig. 7(b) and (c), respectively. When −0.1 V (vs SCE) was applied (Fig. 7(b)), the current density of the 15%Bs sample gradually increased during the entire test; however, the current density of the untreated sample increased in the first 2000s and then decreased in the rest of the test. Accordingly, the current density of the 15%Bs sample was lower than that of the untreated sample within the first 8500s, and then became larger in the rest of the test. When 0.6 V (vs SCE) was applied (Fig. 7(c)), the 15%Bs sample stabilized more quickly than the untreated sample. However, after stabilization the current density of the 15%Bs sample (2.21 × 10^{-6} A/cm²) was slightly higher than that of the untreated sample (1.63 × 10^{-6} A/cm²). It is worth to notice that after 11,000s, the current density of the untreated sample fluctuated strongly, which indicated the failure of passive protect film. In contrast, the current density of the 15%Bs sample was stable in the entire test, which indicated the better long-term stability of the niobium nitride layer.

![Fig. 7](image)

**Fig. 7** — (a) Potentiodynamic polarization curves of ASPA(N + Nb) samples, and potentiostatic polarization results of the untreated sample and the 15%Bs sample under (b) −0.1 V and (c) 0.6 V.

<table>
<thead>
<tr>
<th>Sample</th>
<th>E_{corr} vs SCE (mV)</th>
<th>I_{corr} (mA/cm²)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Untreated</td>
<td>−450</td>
<td>10.3</td>
</tr>
<tr>
<td>5%Bs</td>
<td>−412</td>
<td>9.0</td>
</tr>
<tr>
<td>10%Bs</td>
<td>−362</td>
<td>20.8</td>
</tr>
<tr>
<td>15%Bs</td>
<td>−170</td>
<td>3.2</td>
</tr>
<tr>
<td>ASPN 450-10h-5%</td>
<td>−476</td>
<td>74.8</td>
</tr>
</tbody>
</table>
Surface electrical conductivity

The results of ICR measurements under the compaction force of 140 N/cm² are shown in Fig. 8. In echo of the results reported before [19], ASPN treatment can significantly decrease the ICR value of 316 SS. Compared with the ASPN treated sample, the ICR value of 316 SS was further reduced to below the DOE target (10 mΩ cm²) by simultaneously introducing N and Nb (i.e. ASPA(N + Nb)).

Discussion

The optimal parameters of ASPA(N + Nb) treatment for the application of PEMFC bipolar plates

Two of the most important properties required for high-efficient and long-life bipolar plates are their corrosion resistance and surface electrical conductivity.

It can be seen from Table 2 that the corrosion potential increased with the bias applied and the 15%Bs sample exhibited the highest corrosion potential among all the ASPA(N + Nb) treated samples. Indeed, the corrosion potential of the 15%Bs sample was even higher than that of the untreated material. The results of interfacial contact resistance (ICR) measurement revealed that the ICR values of all the ASPA(N + Nb) samples were around 9 mΩ cm² and their difference was within the range of the experimental error.

Therefore, it follows that the 15%Bs sample exhibited the best combination of corrosion resistance and surface conductivity among all three ASPA(N + Nb) samples and hence the optimal parameters of the ASPA(N + Nb) treatment for the application of PEMFC bipolar plates are at 450 °C for 10 h with a bias of 15%.

However, due to the S-phase formed in the 5%Bs sample (Fig. 6(a)), it is expected that the 5%Bs sample should have a higher load bearing capacity than the 15%Bs sample containing no S-phase case (Fig. 6(b)). Therefore, the 5% bias could be the best treatment if the forming of the PEMFC bipolar plates, such as stamping, needs to be carried out after the surface treatment.

Comparison between the ASPN sample and the ASPA(N + Nb) sample

The experimental results reported have clearly demonstrated that the new hybrid plasma surface engineering process developed based on active-screen plasma co-alloying with both interstitial element of nitrogen and substitutional element of niobium was superior to typical active-screen plasma alloying with nitrogen or active screen plasma nitriding (ASPN) treatment in terms of significantly improved corrosion behaviour and effectively reduced ICR to below 10 mΩ cm². Therefore, it is scientifically interesting and technologically important to understand the mechanism involved.

To this end, by way of example the ASPN and the ASPA(N + Nb) samples treated under the same processing conditions (at 450 °C for 10 h under 0.75 mbar at 5% bias) are compared in Fig. 9. It can be clearly seen that the thickness of the S-phase case (Fig. 9(a)) formed on the ASPN treated sample (10.8 μm) was much thicker than that formed on the ASPN(N + Nb) treated sample (6.3 μm). Not only is the S-phase thickness different for those two samples, but the nitrogen depth profiles (Fig. 9(b)) also show a great difference. As shown in Fig. 9(b), the nitrogen depth profile across the ASPN treated sample was well above that of the ASPA(N + Nb) sample and the former penetrated much deeper than the latter. This could explain the smaller angle shifting of the S-phase peaks in the XRD profile of the 5%Bs ASPA(N + Nb) sample (Fig. 3) than that of the ASPN treated sample.

The comparison of nano-hardness depth profiles of the ASPN treated sample and the ASPA(N + Nb) treated sample is showed in Fig. 9(c). The hardness of the S-phase case formed in the ASPN treated sample was about 14 GPa and the high hardness region extended to a depth around 10 μm. In contrast, the hardness of S-phase formed in the ASPA(N + Nb) treated sample reduced continuously from around 10 GPa at the surface to the substrate value at about 6 μm below the surface. The observed hardness depth distribution in the ASPN and ASPA(N + Nb) treated samples corresponded well with the nitrogen depth distribution, shown in Fig. 9(b).

Clearly, more nitrogen was introduced into the ASPN treated sample than into the ASPA(N + Nb) treated sample when treated under the same temperature, time, pressure and bias conditions. The major difference in nitrogen mass transfer should be attributed to the Nb introduced during the ASPA(N + Nb) treatments in which a Nb-containing active-screen lid was used. It is known that niobium has a high affinity with nitrogen as it is a strong nitride former [33]. Therefore it is reasonable to assume that most of the nitrogen atoms would react with niobium to form niobium nitride during the ASPA(N + Nb) treatments and hence only a small amount of nitrogen atoms could diffuse into the substrate to form S-phase due to the trapping effect of niobium. Accordingly, the thickness of the S-phase case formed in the ASPA(N + Nb) treated sample was only half that formed in the ASPN sample and the nitrogen content of the former was much lower than that of the latter. This is supported by surface layer structure observed for 10%Bs and 15%Bs samples.

Fig. 8 – The ICR values (under 140 N/cm²) of ASPA(N + Nb) treated samples as well as untreated and ASPN treated samples for comparison.
As shown in Fig. 6(d) and (f), further increase in the bias led to the formation of a relatively thick niobium nitride layer on the top of the 10%Bs and 15%Bs samples without measurable S-phase case beneath (Fig. 6(g)). This is because, when increased the bias, Nb was more rapidly sputtered off from the Nb-containing active-screen lid and reacted with nitrogen atoms to form niobium nitride, which deposited onto the sample surface to become a niobium nitride barrier layer for nitrogen diffusion into the subsurface. The formation of Nb$_4$N$_5$ layer was implied by the XRD results shown in Fig. 3 and evidenced by the quantitative XPS results (Fig. 4(g)) that the Nb/N ratio (0.87 and 0.81 for 10%Bs and 15%Bs samples respectively) was close to the theoretical value of Nb$_4$N$_5$ phase (0.80).

In contrast, although the XPS results shown in Fig. 4(a) and (b) confirmed the formation of niobium nitride during the 5%Bs treatment, it is most probably that no continues niobium nitride film was formed on the top of the 5%Bs sample. This is supported by the XPS quantitative composition results (Fig. 4(g)) because the ratio of Nb/N in the 5%Bs surface (0.54) was much lower than the theoretical Nb/N in the XRD detected Nb$_4$N$_5$ phase (0.80). Therefore, nitrogen could still diffuse, despite of trapping by niobium, inward to form a sublayer of S-phase beneath the top Nb-rich layer.

Thus it follows from the discussion above that the new hybrid plasma process developed could produce an in-site formed duplex surface structure consisting of a Nb-rich surface layer followed by a nitrogen supersaturated S-phase case if a low bias of 5% is applied.

The significant improvement in the surface electrical conductivity of 316 SS by the new ASPA(N + Nb) treatments could be contributed to the change of the nature of surface layers. As discussed in introduction, the formation of a passive oxide layer leads to the 'stainliness' of 316 SS; however it also dramatically increases the electrical resistance from 77 $\mu$Ω cm for 316 SS [34] to around $10^8$ $\mu$Ω cm for the surface chromium oxide (Cr$_2$O$_3$) passivation film [35]. In contrast, the surface of the ASPA(N + Nb) treated samples was covered by a niobium nitride layer. The electrical resistance [36] of the surface niobium nitride layer (57 $\mu$Ω cm) is 7 orders of magnitude lower than that of the surface chromium oxide (Cr$_2$O$_3$) passivation film. As a result, the ICR value has been significantly reduced from 316 SS (158 mΩ cm$^2$) to ASPA(N + Nb) treated samples (9 mΩ cm$^2$). From the comparison of ICR in Fig. 8, the ICR value of the ASPA(N + Nb) treated samples was also much lower than that of the typical ASPN treated samples. This is mainly because chromium oxide can still form on the

![Fig. 9](image-url) - (a) the S-phase thickness, (b) atomic percentage of nitrogen profiles against depth and (c) nano-hardness profiles of ASPN and ASPA(N + Nb) samples treated at 450 °C for 10 h with 5% bias.
surface of S-phase formed in austenite stainless steel by the ASPN treatments [37].

Apart from the effectively improved surface electrical conductivity, the corrosion resistance of the ASPA(N + Nb) treated samples was also superior to that of the typical ASPN treated samples in terms of reduced corrosion current density and increased corrosion potential. This could be attributed to the formation of surface niobium nitride layer by the ASPA(N + Nb) treatment in view of the superior corrosion resistance of the niobium nitride [38]. As reported in our previous paper [19], the surface of the ASPN treated 316 SS is covered by a layer of iron nitrides [39], which exhibits poor corrosion behaviour than niobium nitride. The slightly higher passive current density of the ASPA(N + Nb) treated 316 SS relative to that of the untreated material could be related to the corrosion of iron embedded in the niobium nitride layer (Fig. 5).

Conclusions

A new hybrid plasma surface co-alloying process has been successfully developed to simultaneously alloy 316 austenitic stainless steel (316 SS) surfaces with both nitrogen and niobium. By adjusting the treatment condition, the layer structure of the modified surfaces can be tailored. When treated under a low applied bias of 5%, a duplex surface layer structure consisting of a very thin niobium nitride surface layer followed by an S-phase case can be produced; however, when treated under high applied bias (10–15%), only a niobium nitride layer can be formed on the surface without the formation of S-phase case underneath.

The electrochemical corrosion resistance and the interfacial contact resistance (ICR) of the ASPA(N + Nb) treated surfaces have been evaluated and compared with untreated and typical active screen plasma nitried (ASPN) surfaces. The electrochemical corrosion tests have revealed that the corrosion potential of 316 SS can be increased by all three ASPA(N + Nb) treatments but the passive current density of the treated samples was higher than that of the untreated one; the ASPA(N + Nb) treated samples were superior to the ASPN treated ones in terms of increased corrosion potential and reduced passive current density. Among the three ASPA(N + Nb) treated samples, the 15% Bs sample exhibited the best corrosion resistance.

The results of interfacial contact resistance tests show that the ICR values of all three ASPA(N + Nb) treated samples were about 9 mΩ cm². This is about 18 and 3.6 times lower than that of the untreated and ASPN treated 316 SS, respectively, which is also lower than the DOE target (10 mΩ cm²).

Taking the corrosion properties and interfacial contact resistant into account, the ASPA(N + Nb) treatment at 15% bias (15% Bs) is the best treatment potentially for the application of PEMFC bipolar plates.

Further tests, such as single cell tests and long-duration corrosion tests, are needed to evaluate the performance of the ASPA(N + Nb) treated 316 stainless steel bipolar plates in the real PEMFC working environment.

Acknowledgements

The financial support from European Commission (PIIC-GA-2012-327750) and EPSRC (EP/J018252/1) is gratefully acknowledged. One of the authors (KL) wishes to express his appreciation to China Scholarship Council (CSC) and The University of Birmingham for their PhD studentships.

References


